MOSFET - Power, Single N-Channel, μ8FL 30 V, 17 mΩ, 22 A

NVTFS4C25N

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- NVTFS4C25NWF Wettable Flanks Product
- NVT Prefix for Automotive and Other Applications Requiring Unique Site and Control Change Requirements; AEC-Q101 Qualified and PPAP Capable
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise stated)

Param	Symbol	Value	Unit		
Drain-to-Source Voltage	V_{DSS}	30	V		
Gate-to-Source Voltage	V _{GS}	±20	V		
Continuous Drain		T _A = 25°C	I _D	10.1	Α
Current $R_{\theta JA}$ (Notes 1, 3, 5)	Steady State	T _A = 85°C		7.8	
Power Dissipation R _{θJA}		T _A = 25°C	P _D	3.0	W
(Notes 1, 3, 5)		T _A = 85°C	1	1.8]
Continuous Drain	Steady State	T _C = 25°C	I _D	22.1	Α
Current $R_{\psi JC}$ (Notes 1, 2, 4, 5)		T _C = 85°C	<u> </u>	17.1	
Power Dissipation		T _C = 25°C	P _D	14.3	W
R _{ψJC} (Notes 1, 2, 4, 5)		T _C = 85°C		8.6	
Pulsed Drain Current	T _A = 25°0	C, t _p = 10 μs	I _{DM}	90	Α
Operating Junction and S	T _J , T _{stg}	-55 to +175	°C		
Source Current (Body Did	I _S	14	Α		
Single Pulse Drain-to-So (T _J = 25°C, I _L = 6.7 A _{pk} , L	E _{AS}	11.2	mJ		
Lead Temperature for So (1/8" from case for 10 s)	TL	260	°C		

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.
- 2. Psi (ψ) is used as required per JESD51-12 for packages in which substantially less than 100% of the heat flows to a single case surface.
- 3. Surface-mounted on FR4 board using 650 mm², 2 oz. Cu Pad.
- Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.
- 5. Continuous DC current rating. Maximum current for pulses as long as one second is higher but dependent on pulse duration and duty cycle.

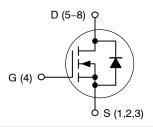


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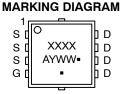
V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	17 mΩ @ 10 V	22 A
30 V	26.5 mΩ @ 4.5 V	22.8

N-Channel MOSFET





WDFN8 (μ8FL) CASE 511AB



4C25 = Specific Device Code for

NVMTS4C25N

25WF = Specific Device Code of

NVTFS4C25NWF

A = Assembly Location

Y = Year

WW = Work Week

= Pb-Free Package
 (Note: Microdot may be in either location)

ORDERING INFORMATION

See detailed ordering and shipping information on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain) (Notes 6, 7 and 9)	$\Psi_{ heta extsf{JC}}$	10.5	°C/W
Junction-to-Ambient - Steady State (Notes 6 and 8)	$R_{ heta JA}$	50	C/VV

- 6. The entire application environment impacts the thermal resistance values shown; they are not constants and are valid for the specific conditions noted.
- 7. Psi (ψ) is used as required per JESD51–12 for packages in which substantially less than 100% of the heat flows to a single case surface. 8. Surface–mounted on FR4 board using 650 mm², 2 oz. Cu Pad.
- 9. Assumes heat-sink sufficiently large to maintain constant case temperature independent of device power.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•						
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D :	= 250 μΑ	30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /				15.3		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	$V_{GS} = 0 \text{ V}, \\ V_{DS} = 24 \text{ V}$ $T_J = 25^{\circ}\text{C}$ $T_J = 125^{\circ}\text{C}$				1.0	
						10	μΑ
Gate-to-Source Leakage Current	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS}$	_S = ±20 V			±100	nA
ON CHARACTERISTICS (Note 10)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_{D}$	= 250 μΑ	1.3		2.2	V
Threshold Temperature Coefficient	V _{GS(TH)} /T _J				-4.5		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 10 A		13	17	0
		V _{GS} = 4.5 V	I _D = 9 A		21	26.5	mΩ
Forward Transconductance	9FS	V _{DS} = 1.5 V, I	_D = 15 A		23		S
Gate Resistance	R_{G}	T _A = 25°C			1.0		Ω
CHARGES AND CAPACITANCES							
Input Capacitance	C _{ISS}	V _{GS} = 0 V, f = 1 MHz, V _{DS} = 15 V			500		pF
Output Capacitance	C _{OSS}				295		
Reverse Transfer Capacitance	C _{RSS}				85		
Capacitance Ratio	C _{RSS} /C _{ISS}	V _{GS} = 0 V, V _{DS} = 15 V, f = 1 MHz			0.170		
Total Gate Charge	Q _{G(TOT)}				5.1		
Threshold Gate Charge	Q _{G(TH)}				0.9		nC
Gate-to-Source Charge	Q_{GS}	$V_{GS} = 4.5 \text{ V}, V_{DS} =$	15 V; I _D = 20 A		1.7		
Gate-to-Drain Charge	Q_{GD}				2.7		
Gate Plateau Voltage	V_{GP}				3.3		V
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} =	15 V; I _D = 20 A		10.3		nC
SWITCHING CHARACTERISTICS (Note 1	1)						
Turn-On Delay Time	t _{d(ON)}				8.0		
Rise Time	t _r	VGS = 4.5 V. Vr	ns = 15 V.		32		1
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 10 \text{ A}, R_{G} = 3.0 \Omega$			10		ns
Fall Time	t _f				3.0]
Turn-On Delay Time	t _{d(ON)}				4.0		
Rise Time	t _r	V _{GS} = 10 V, V _r	os = 15 V,		25		
Turn-Off Delay Time	t _{d(OFF)}	$V_{GS} = 10 \text{ V}, V_{DS} = 15 \text{ V},$ $I_{D} = 15 \text{ A}, R_{G} = 3.0 \Omega$			13		ns
Fall Time	t _f				2.0		1

^{10.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%.

^{11.} Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise specified)

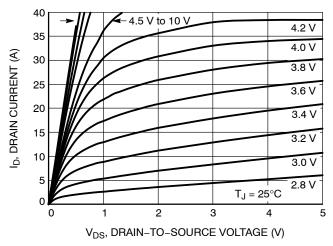
Parameter	Symbol	Test Cond	Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V, I _S = 10 A	$T_J = 25^{\circ}C$		0.87	1.2	V
		I _S = 10 A	T _J = 125°C		0.75		\ \ \
Reverse Recovery Time	t _{RR}				18.2		
Charge Time	ta	V_{GS} = 0 V, dIS/dt = 100 A/ μ s, I _S = 30 A			9.8		ns
Discharge Time	t _b				8.4		
Reverse Recovery Charge	Q _{RR}	1		5.7		nC	

^{10.} Pulse Test: pulse width \leq 300 μ s, duty cycle \leq 2%. 11. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

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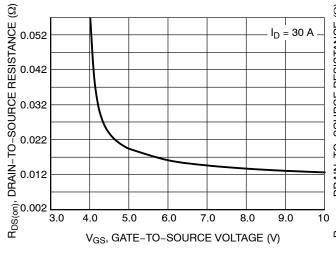
 $V_{DS} = 5 V$



ID, DRAIN CURRENT (A) 30 20 $T_J = 125^{\circ}C$ 10 T_J = 25°C = -55°C 0 0.5 1.0 1.5 2.0 2.5 3.0 3.5 4.0 V_{GS}, GATE-TO-SOURCE VOLTAGE (V)

Figure 1. On-Region Characteristics

Figure 2. Transfer Characteristics



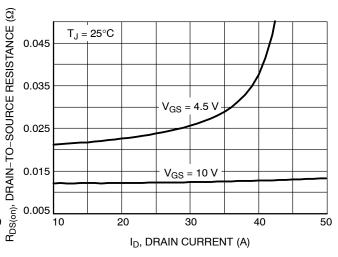
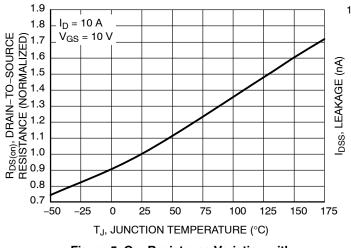


Figure 3. On-Resistance vs. V_{GS}

Figure 4. On-Resistance vs. Drain Current and Gate Voltage



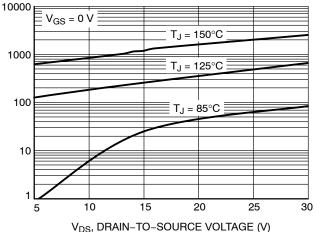


Figure 5. On–Resistance Variation with Temperature

Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

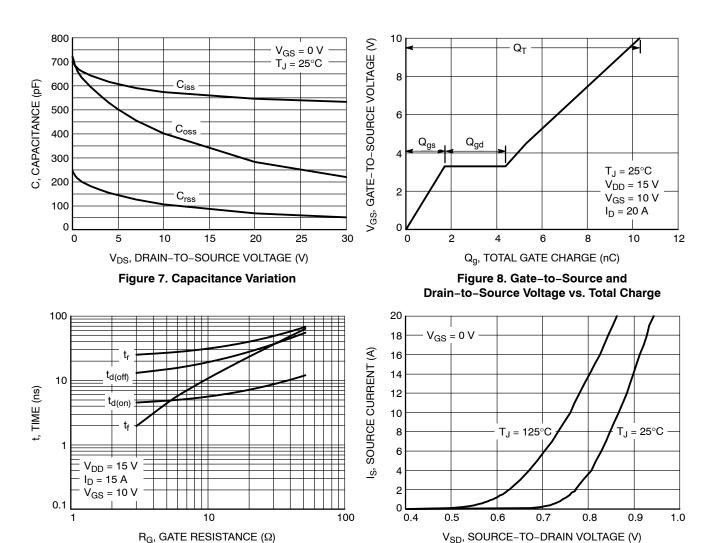


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

Figure 10. Diode Forward Voltage vs. Current

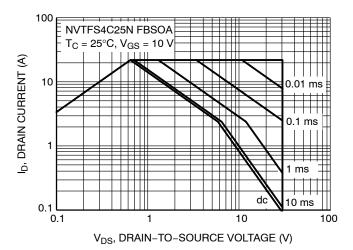


Figure 11. Maximum Rated Forward Biased Safe Operating Area

TYPICAL CHARACTERISTICS

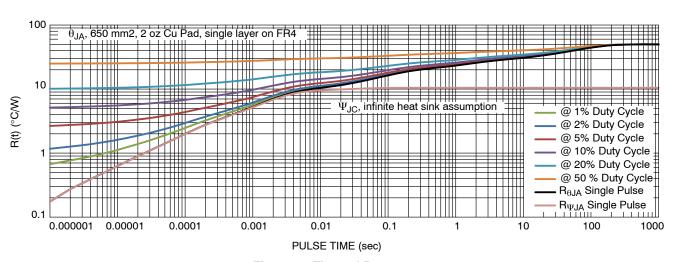


Figure 12. Thermal Response

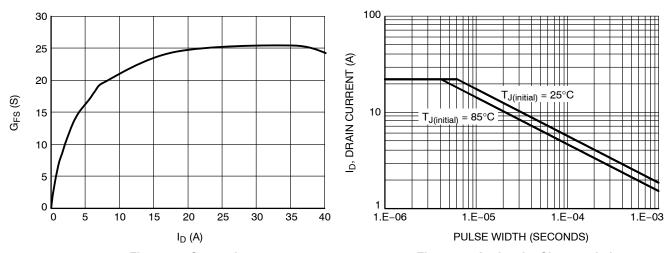


Figure 13. G_{FS} vs. I_D

Figure 14. Avalanche Characteristics

ORDERING INFORMATION

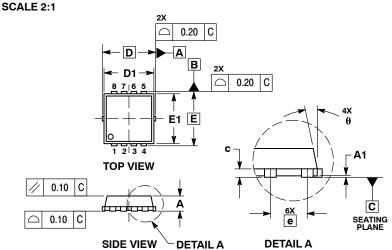
Device	Marking	Package	Shipping [†]
NVTFS4C25NTAG	4C25	WDFN8 (Pb-Free)	1500 / Tape & Reel
NVTFS4C25NWFTAG	25WF	WDFN8 (Pb-Free)	1500 / Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.



WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

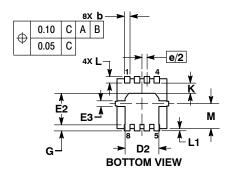
DATE 23 APR 2012



NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
 CONTROLLING DIMENSION: MILLIMETERS.
 DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
 PROTRUSIONS OR GATE BURRS.

	МІ	LLIMETE	RS		INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC)
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E		3.30 BSC		O	.130 BSC)
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			(0.026 BS0	2
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



GENERIC MARKING DIAGRAM*

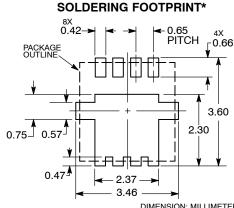


XXXXX = Specific Device Code = Assembly Location

= Year WW = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking.

Pb-Free indicator, "G" or microdot " ■", may or may not be present.



DIMENSION: MILLIMETERS

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	WDFN8 3.3X3.3. 0.65P		PAGE 1 OF 1	

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